

IGBT - Field Stop, Trench

650 V, 75 A

FGHL75T65LQDTL4

Description

Field stop 4th generation Low $V_{CE(sat)}$ IGBT technology and Full current rated copack Diode technology.

Features

- Maximum Junction Temperature: $T_J = 175^{\circ}\text{C}$
- Positive Temperature Co-efficient for Easy Parallel Operating
- High Current Capability
- Low Saturation Voltage: $V_{CE(sat)} = 1.15\text{ V (Typ.) @ } I_C = 75\text{ A}$
- 100% of the Part are Tested for I_{LM} (Note 2)
- Smooth & Optimized Switching
- Tight Parameter Distribution
- Co-Packed with Soft and Fast Recovery Diode
- RoHS Compliant

Typical Applications

- Solar Inverter
- UPS, ESS
- PFC, Converters

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector to Emitter Voltage	V_{CES}	650	V
Gate to Emitter Voltage	V_{GES}	± 20	V
Transient Gate to Emitter Voltage		± 30	
Collector Current @ $T_C = 25^{\circ}\text{C}$ (Note 1)	I_C	80	A
Collector Current @ $T_C = 100^{\circ}\text{C}$		75	
Pulsed Collector Current (Note 2)	I_{LM}	300	A
Pulsed Collector Current (Note 3)	I_{CM}	300	A
Diode Forward Current @ $T_C = 25^{\circ}\text{C}$ (Note 1)	I_F	80	A
Diode Forward Current @ $T_C = 100^{\circ}\text{C}$		75	
Pulsed Diode Maximum Forward Current	I_{FM}	300	A
Maximum Power Dissipation @ $T_C = 25^{\circ}\text{C}$	P_D	469	W
Maximum Power Dissipation @ $T_C = 100^{\circ}\text{C}$		234	
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 to $+175$	$^{\circ}\text{C}$
Maximum Lead Temp. for Soldering Purposes (1/8" from case for 5 s)	T_L	260	$^{\circ}\text{C}$

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

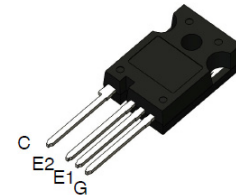
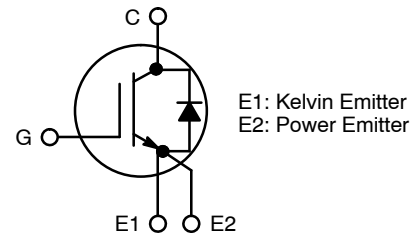
1. Value limit by bond wire.
2. $V_{CC} = 400\text{ V}$, $V_{GE} = 15\text{ V}$, $I_C = 300\text{ A}$, Inductive Load, 100% Tested.
3. Repetitive rating: Pulse width limited by max. Junction temperature.



ON Semiconductor®

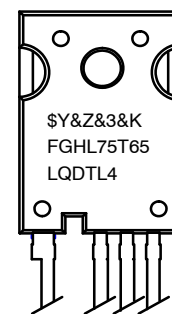
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V_{CES}	I_C	$V_{CE(sat)}$
650 V	75 A	1.15 V



TO-247-4LD
CASE 340CJ

MARKING DIAGRAM



$\$Y$ = ON Semiconductor Logo
 $\&Z$ = Assembly Plant Code
 $\&3$ = 3-Digit Data Code
 $\&K$ = 2-Digit Lot Traceability Code
 FGHL75T65LQDTL4 = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping
FGHL75T65LQDTL4	TO-247-4LD	30 Units / Rail

FGHL75T65LQDTL4

THERMAL CHARACTERISTICS

Rating	Symbol	Value	Unit
Thermal Resistance Junction-to-Case, for IGBT	$R_{\theta JC}$	0.32	$^{\circ}\text{C/W}$
Thermal Resistance Junction-to-Case, for Diode	$R_{\theta JC}$	0.48	$^{\circ}\text{C/W}$
Thermal Resistance Junction-to-Ambient	$R_{\theta JA}$	40	$^{\circ}\text{C/W}$

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}\text{C}$ unless otherwise specified)

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Collector to Emitter Breakdown Voltage	$V_{GE} = 0\text{ V}, I_C = 1\text{ mA}$	BV_{CES}	650	–	–	V
Temperature Coefficient of Breakdown Voltage	$V_{GE} = 0\text{ V}, I_C = 1\text{ mA}$	$\Delta BV_{CES} / \Delta T_J$	–	0.6	–	$\text{V}/^{\circ}\text{C}$
Collector to Emitter Cut-off Current	$V_{GE} = 0\text{ V}, V_{CE} = 650\text{ V}$	I_{CES}	–	–	250	μA
Gate Leakage Current	$V_{GE} = 20\text{ V}, V_{CE} = 0\text{ V}$	I_{GES}	–	–	± 400	nA

ON CHARACTERISTICS

Gate to Emitter Threshold Voltage	$V_{GE} = V_{CE}, I_C = 75\text{ mA}$	$V_{GE(th)}$	3.0	4.5	6.0	V
Collector to Emitter Saturation Voltage	$V_{GE} = 15\text{ V}, I_C = 75\text{ A}, T_J = 25^{\circ}\text{C}$ $V_{GE} = 15\text{ V}, I_C = 75\text{ A}, T_J = 175^{\circ}\text{C}$	$V_{CE(sat)}$	– –	1.15 1.22	1.35 –	V

DYNAMIC CHARACTERISTICS

Input Capacitance	$V_{CE} = 30\text{ V}, V_{GE} = 0\text{ V}, f = 1\text{ MHz}$	C_{ies}	–	15030	–	pF
Output Capacitance		C_{oes}	–	181	–	
Reverse Transfer Capacitance		C_{res}	–	68	–	
Gate Charge Total	$V_{CC} = 400\text{ V}, I_C = 75\text{ V}, V_{GE} = 15\text{ V}$	Q_g	–	779	–	nC
Gate to Emitter Charge		Q_{ge}	–	69	–	
Gate to Collector Charge		Q_{gc}	–	251	–	

SWITCHING CHARACTERISTICS, INDUCTIVE LOAD

Turn-on Delay Time	$T_J = 25^{\circ}\text{C},$ $V_{CC} = 400\text{ V}, I_C = 37.5\text{ A},$ $R_G = 4.7\ \Omega,$ $V_{GE} = 15\text{ V}$	$t_{d(on)}$	–	40	–	ns
Rise Time		t_r	–	12	–	
Turn-off Delay Time		$t_{d(off)}$	–	560	–	
Fall Time		t_f	–	144	–	
Turn-on Switching Loss		E_{on}	–	0.51	–	mJ
Turn-off Switching Loss		E_{off}	–	1.39	–	
Total Switching Loss		E_{ts}	–	1.9	–	
Turn-on Delay Time	$T_J = 25^{\circ}\text{C},$ $V_{CC} = 400\text{ V}, I_C = 75\text{ A},$ $R_G = 4.7\ \Omega,$ $V_{GE} = 15\text{ V}$	$t_{d(on)}$	–	40	–	ns
Rise Time		t_r	–	20	–	
Turn-off Delay Time		$t_{d(off)}$	–	548	–	
Fall Time		t_f	–	112	–	
Turn-on Switching Loss		E_{on}	–	1.01	–	mJ
Turn-off Switching Loss		E_{off}	–	2.53	–	
Total Switching Loss		E_{ts}	–	3.54	–	

FGHL75T65LQDTL4

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified) (continued)

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
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SWITCHING CHARACTERISTICS, INDUCTIVE LOAD

Turn-on Delay Time	T _J = 175°C, V _{CC} = 400 V, I _C = 37.5 A, R _G = 4.7 Ω, V _{GE} = 15 V	t _{d(on)}	–	32	–	ns
Rise Time		t _r	–	16	–	
Turn-off Delay Time		t _{d(off)}	–	640	–	
Fall Time		t _f	–	212	–	
Turn-on Switching Loss	T _J = 175°C, V _{CC} = 400 V, I _C = 75 A, R _G = 4.7 Ω, V _{GE} = 15 V	E _{on}	–	1.45	–	mJ
Turn-off Switching Loss		E _{off}	–	2	–	
Total Switching Loss		E _{ts}	–	3.45	–	
Turn-on Delay Time	T _J = 175°C, V _{CC} = 400 V, I _C = 75 A, R _G = 4.7 Ω, V _{GE} = 15 V	t _{d(on)}	–	36	–	ns
Rise Time		t _r	–	28	–	
Turn-off Delay Time		t _{d(off)}	–	616	–	
Fall Time		t _f	–	168	–	
Turn-on Switching Loss	T _J = 175°C, V _{CC} = 400 V, I _C = 75 A, R _G = 4.7 Ω, V _{GE} = 15 V	E _{on}	–	2.4	–	mJ
Turn-off Switching Loss		E _{off}	–	3.64	–	
Total Switching Loss		E _{ts}	–	6.04	–	

DIODE CHARACTERISTICS

Diode Forward Voltage	I _F = 75 A, T _J = 25°C I _F = 75 A, T _J = 175°C	V _F	– –	1.65 1.55	2.1 –	V
Reverse Recovery Energy	T _J = 25°C, V _R = 400 V, I _F = 37.5 A, di _F /dt = 1000 A/μs	E _{REC}	–	105	–	μJ
Reverse Recovery Time		T _{rr}	–	59	–	ns
Reverse Recovery Charge		Q _{rr}	–	574	–	nC
Reverse Recovery Current		I _{rr}	–	20	–	A
Reverse Recovery Energy	T _J = 25°C, V _R = 400 V, I _F = 75 A, di _F /dt = 1000 A/μs	E _{REC}	–	152	–	μJ
Reverse Recovery Time		T _{rr}	–	87	–	ns
Reverse Recovery Charge		Q _{rr}	–	794	–	nC
Reverse Recovery Current		I _{rr}	–	18	–	A
Reverse Recovery Energy	T _J = 175°C, V _R = 400 V, I _F = 37.5 A, di _F /dt = 1000 A/μs	E _{REC}	–	550	–	μJ
Reverse Recovery Time		T _{rr}	–	119	–	ns
Reverse Recovery Charge		Q _{rr}	–	2154	–	nC
Reverse Recovery Current		I _{rr}	–	36	–	A
Reverse Recovery Energy	T _J = 175°C, V _R = 400 V, I _F = 75 A, di _F /dt = 1000 A/μs	E _{REC}	–	764	–	μJ
Reverse Recovery Time		T _{rr}	–	145	–	ns
Reverse Recovery Charge		Q _{rr}	–	2947	–	nC
Reverse Recovery Current		I _{rr}	–	40	–	A

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

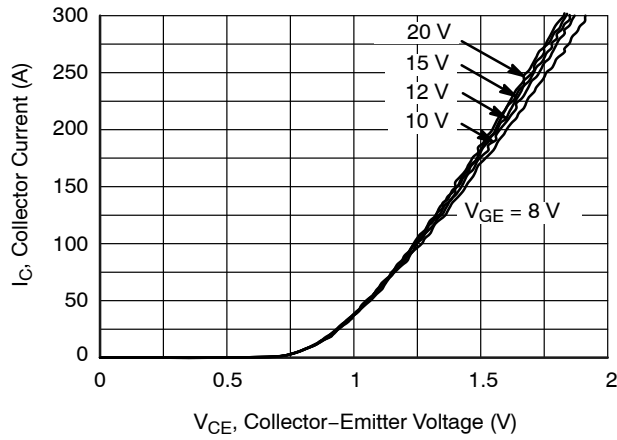


Figure 1. Typical Output Characteristics
($T_J = 25^\circ\text{C}$)

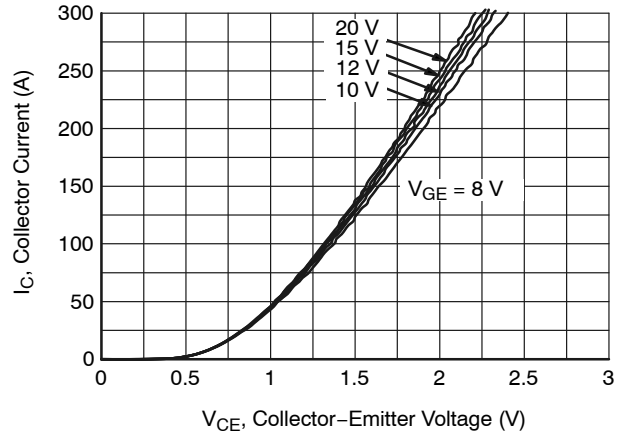


Figure 2. Typical Output Characteristics
($T_J = 175^\circ\text{C}$)

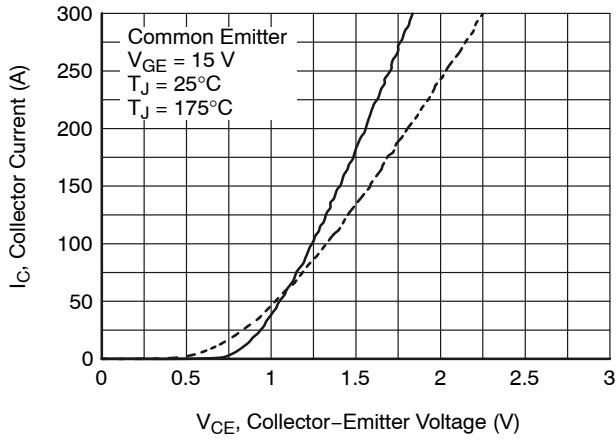


Figure 3. Typical Saturation Voltage Characteristics

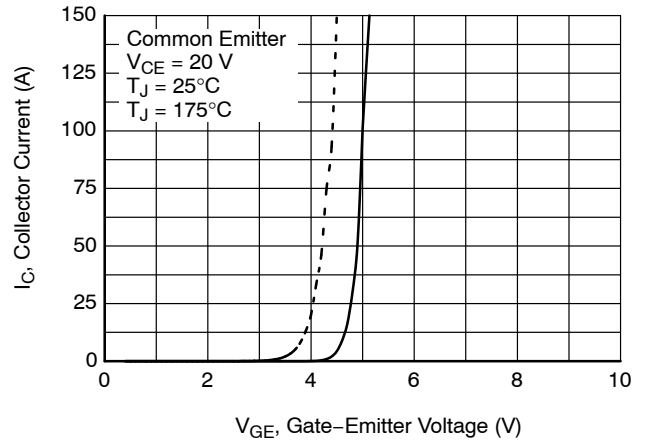


Figure 4. Typical Transfer Characteristics

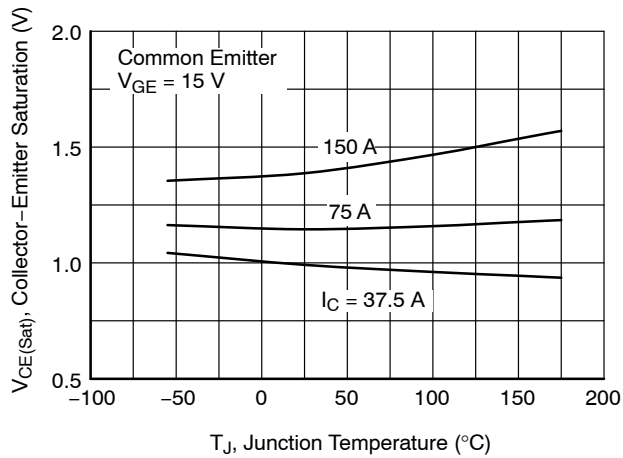


Figure 5. Saturation Voltage vs. Junction Temperature

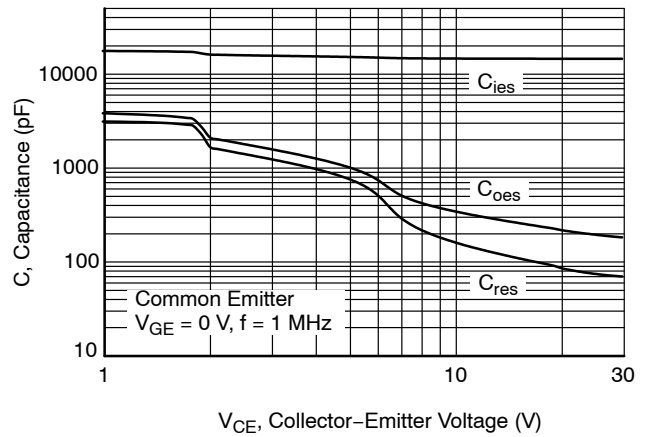


Figure 6. Capacitance Characteristics

TYPICAL CHARACTERISTICS (continued)

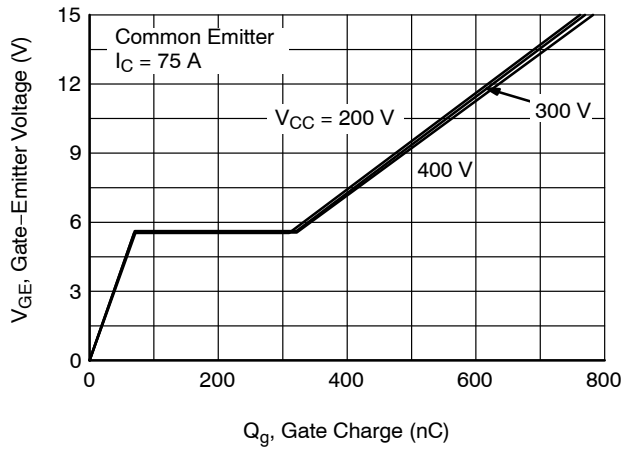


Figure 7. Gate Charge Characteristics

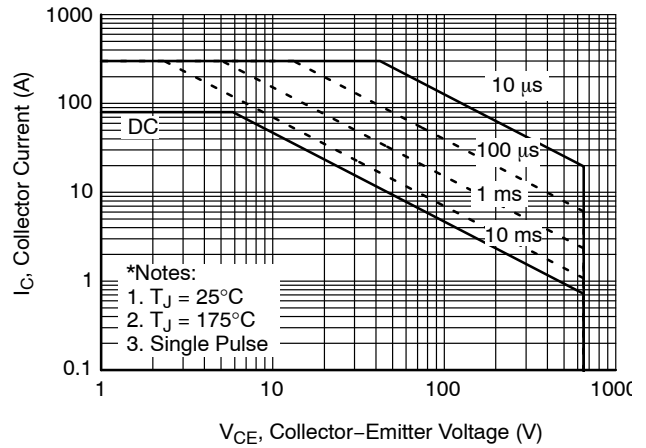


Figure 8. SOA Characteristics

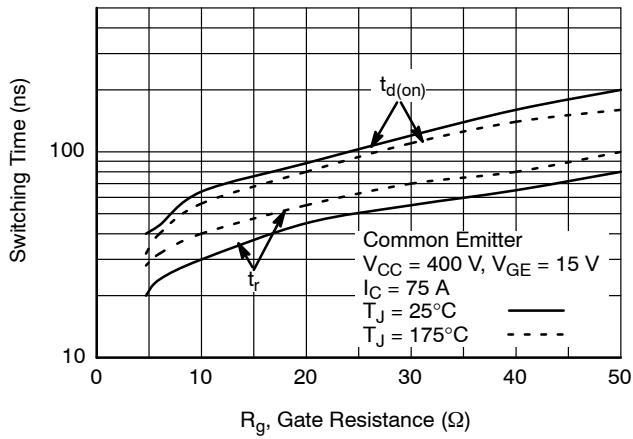


Figure 9. Turn-On Characteristics vs. Gate Resistance

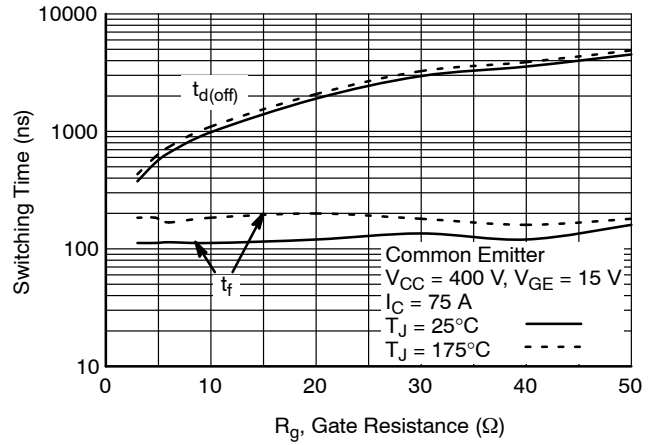


Figure 10. Turn-Off Characteristics vs. Gate Resistance

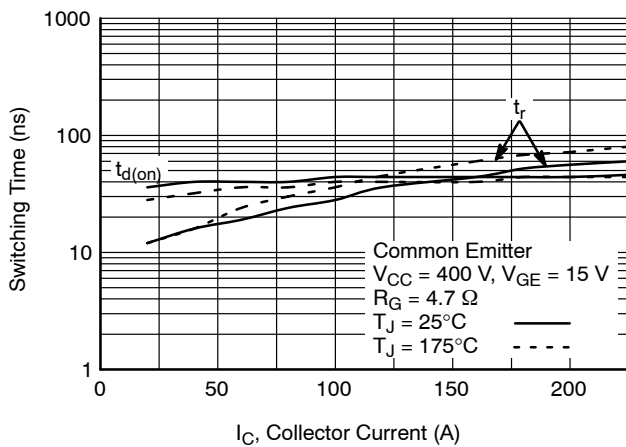


Figure 11. Turn-On Characteristics vs. Collector Current

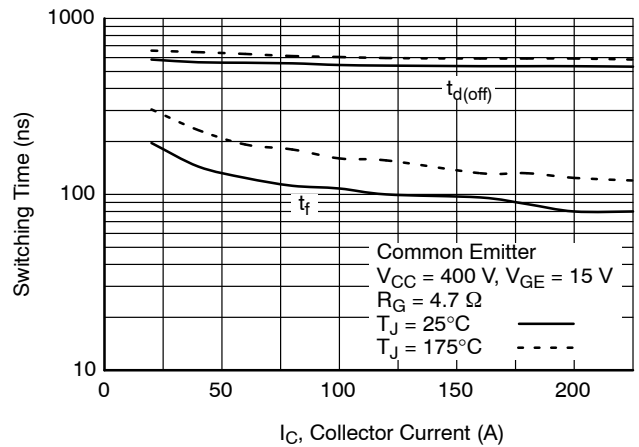


Figure 12. Turn-Off Characteristics vs. Collector Current

FGHL75T65LQDTL4

TYPICAL CHARACTERISTICS (continued)

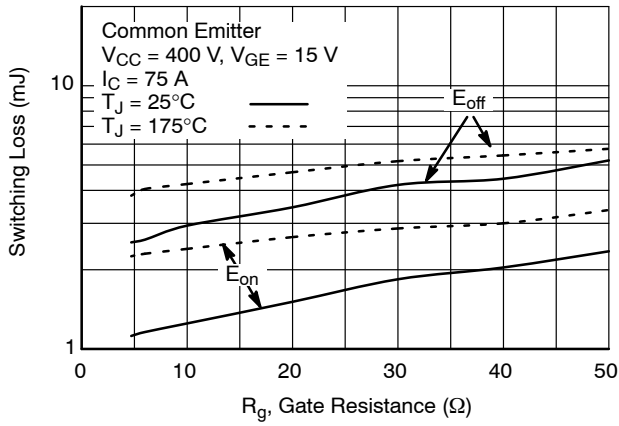


Figure 13. Switching Loss vs. Gate Resistance

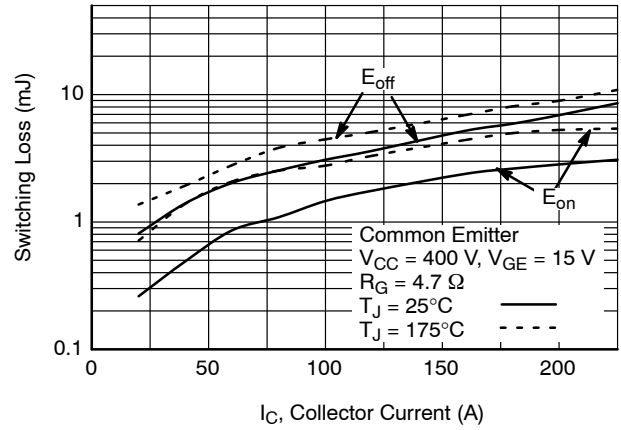


Figure 14. Switching Loss vs. Collector Current

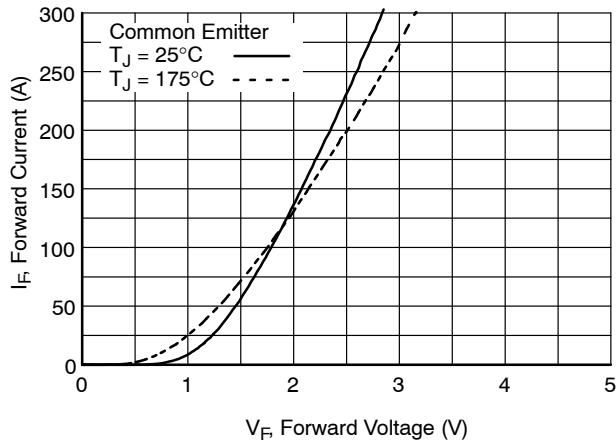


Figure 15. Forward Characteristics

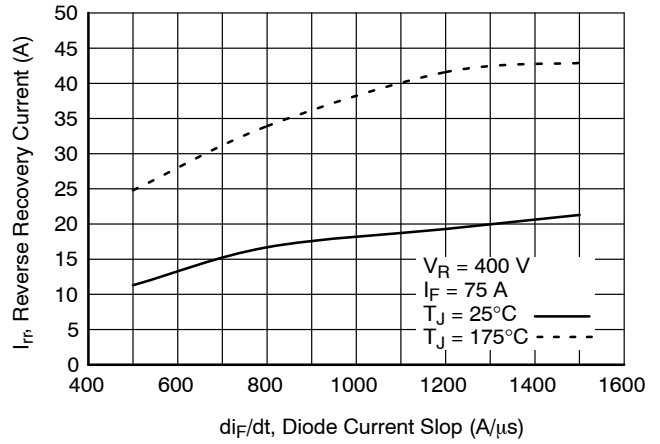


Figure 16. Reverse Recovery Current

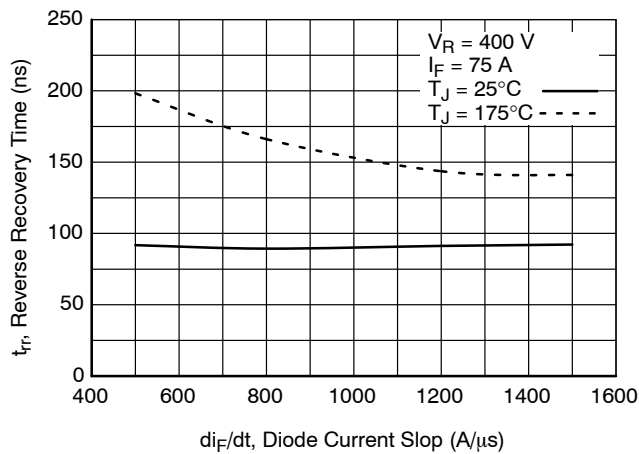


Figure 17. Reverse Recovery Time

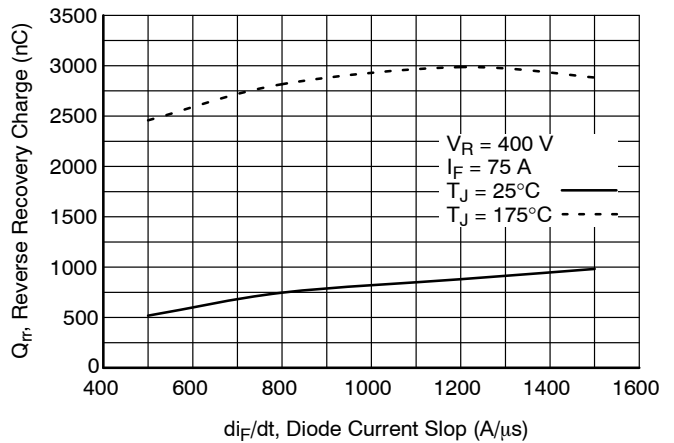


Figure 18. Stored Charge

TYPICAL CHARACTERISTICS (continued)

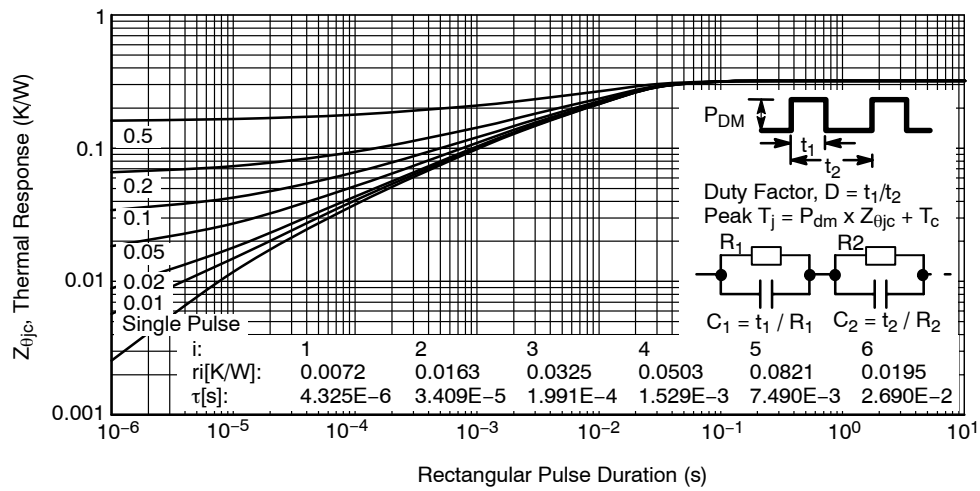


Figure 19. Transient Thermal Impedance of IGBT

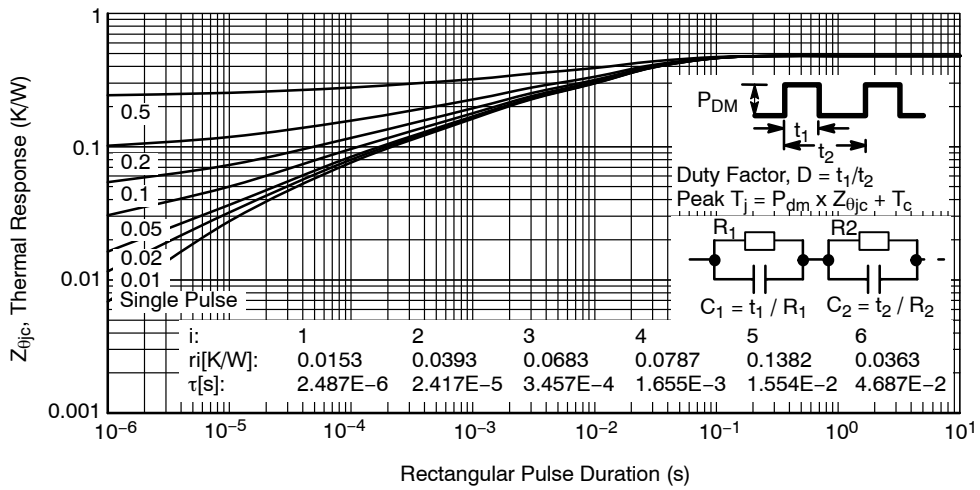
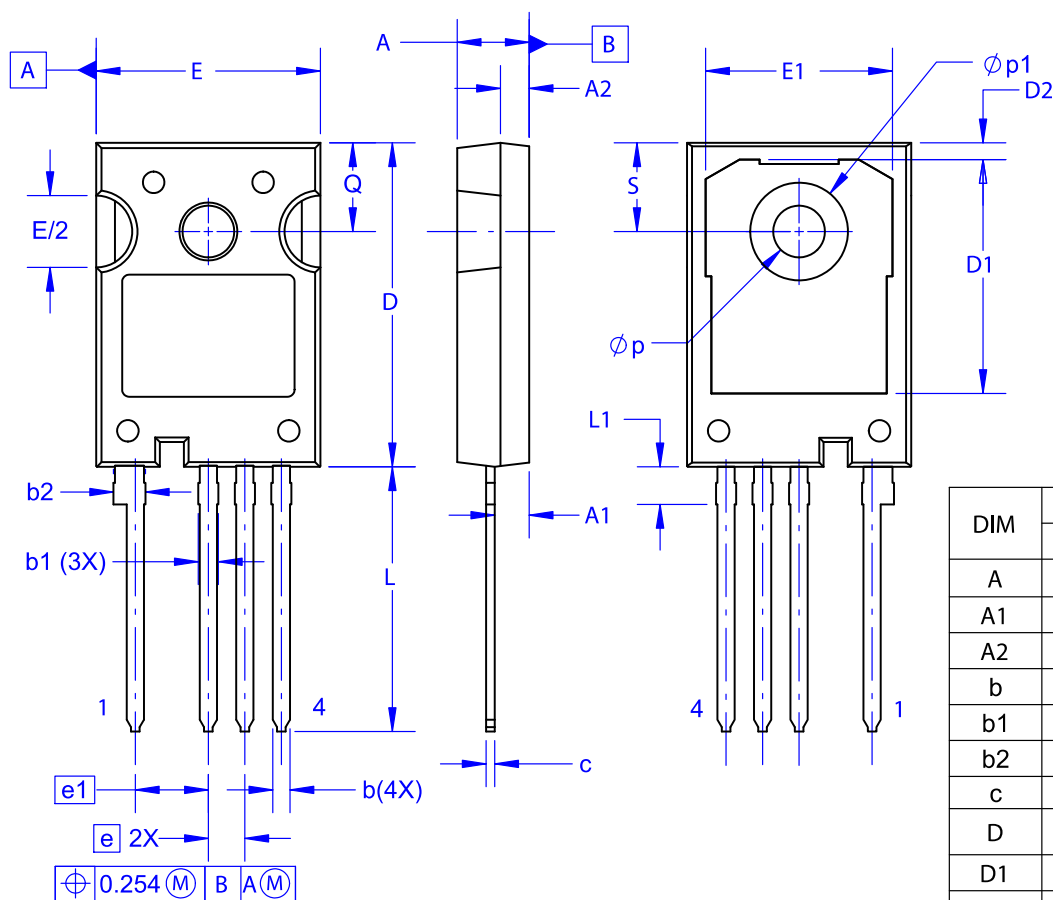


Figure 20. Transient Thermal Impedance of Diode

TO-247-4LD
CASE 340CJ
ISSUE A

DATE 16 SEP 2019



NOTES:

- A. NO INDUSTRY STANDARD APPLIES TO THIS PACKAGE.
B. DIMENSIONS ARE EXCLUSIVE OF BURRS,MOLD
FLASH,AND TIE BAR EXTRUSIONS.
C. ALL DIMENSIONS ARE IN MILLIMETERS.
D. DRAWING CONFORMS TO ASME Y14.5-2009.

DIM	MILLIMETERS		
	MIN	NOM	MAX
A	4.80	5.00	5.20
A1	2.10	2.40	2.70
A2	1.80	2.00	2.20
b	1.07	1.20	1.33
b1	1.20	1.40	1.60
b2	2.02	2.22	2.42
c	0.50	0.60	0.70
D	22.34	22.54	22.74
D1	16.00	16.25	16.50
D2	0.97	1.17	1.37
e	2.54 BSC		
e1	5.08 BSC		
E	15.40	15.60	15.80
E1	12.80	13.00	13.20
E/2	4.80	5.00	5.20
L	18.22	18.42	18.62
L1	2.42	2.62	2.82
p	3.40	3.60	3.80
p1	6.60	6.80	7.00
Q	5.97	6.17	6.37
S	5.97	6.17	6.37

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